Hipot Tester with Insulation Resistance Test

Perfect design for System Operation, introducing our top of the line of Hipot / Insulation Resistance Testers





TOS9201(AC/DC) TOS9200(AC)

Capable of performing hipot and insulation testing in comply with safety standards, including IEC, EN, VDE, BS, UL,CSA, JIS and the Electrical Application and Material Safety Law (Japan)

The TOS9200 Series has been developed to meet a wide diversity of customer needs. Including the refinement and enforcement of Kikusui's former series, its specifications reflect the results of detailed study of our large database of user's requirements including special orders and modifying specifications.

The TOS9200 Series consists of four products : the testers TOS9200 and TOS9201, and the high-voltage scanners TOS9221 and TOS9220. The TOS9200 is equipped with AC hipot and insulation resistance testing functions, while the TOS9201 has a DC hipot testing function in addition to these two functions. The power block, a core component, employs a high-efficiency switching power supply and a switching amplifier based on PWM systems. These features realize high power and enhanced stability, as well as reducing the size and weight of the unit. When combined with the ground bond tester TOS6200, the TOS9200 Series integrates three or four types of tests in a single process.

Furthermore, when used together with the high-voltage scanner TOS9220/9221 (equipped with a contact check function), the tester is capable of automatically checking test points for up to 16 channels, thereby facilitating a safe, reliable automatic testing system.

RS-232C

DRIVERS

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- Rise-time control function
- Fall-time control function
- Offset cancel function
- Measured-value hold function

GPIB

- Output voltage monitoring function
- Memory function
- Program function
- Interlock function
- DC discharge function

Basic performance

Three functions - AC hipot testing, DC hipot testing and insulation resistance testing

The TOS9200 can perform AC hipot tests and insulation resistance tests, while the TOS9201 can also conduct DC withstanding tests. Once connected to a device being tested, the TOS9201 executes an AC hipot test, DC hipot test, and insulation resistance testing in succession in one process.

AC hipot testing at 5 kV and 100 mA

Equipped with a high-efficiency switching power supply in its highvoltage power block, a PWM-based switching amplifier and a 500 VA high-voltage transformer, the TOS9200/TOS9201 realizes a maximum output of 5 kV/100 mA (continuous output for 30 minutes), or 2.5 times the output of Kikusui's former models. At a test voltage of 500 V or more and an upper current of 100 mA, or greater the tester instantaneously satisfies the requirements of a short-circuit current of 200 mA or more which is required by the IEC standard *. In addition, the tester ensures a load effects of 30% or less and the generation of a consistent 50 Hz/60 Hz test voltage free from the affect of the supply voltage. These features eliminate the need to readjust the output voltage once the test voltage is preset.

*Continuous outputs are impossible because the output is cut off if an overcurrent is detected.

DC hipot testing at 6 kV and a maximum output of 50 W

The TOS9201 permits DC hipot testing at up to 6 kV * . The tester is equipped with a stable, low-ripple DC/DC converter with a load factor of 1% or less.

*Maximum output of 50 W for up to 1 minute.

Insulation resistance testing at 25 V to 1000 V and 0.01 M Ω to 9.99 G Ω . The test voltage can be set to 25 V through 1000 V at a resolution

The test voltage can be	set to 25 v thin	ough 1000 v at a resolution
of 1 V. Insulation	Test voltage	Resistance measurement range
resistance covers a	25V	0.03 $\text{M}\Omega$ to 500 $\text{M}\Omega$
wide measurement	50V	0.05 M Ω to 1.00 G Ω
range from 0.01 $\mbox{M}\Omega$ to	100V	0.10 $M\Omega$ to 2.00 $G\Omega$
9.99 GΩ *.	125V	0.13 $M\Omega$ to 2.50 $G\Omega$
A single unit of the	250V	0.25 $\text{M}\Omega$ to 5.00 $\text{G}\Omega$
TOS9200/9201 is	500V	0.50 M Ω to 9.99 G Ω
capable of handling	1000V	1.00 M Ω to 9.99 G Ω

all test voltages required by JIS C 1302 1994 (Insulation Resistor Meter) and fully meets the JIS requirements.

*At a maximum rated current of 1 mA to 50 nA.

Enhanced measurement accuracy

The TOS9200/9201 is provided with a digital voltmeter for hipot testing at an accuracy of $\pm(1\%$ of reading + 30 V) and another one for insulation resistance testing at an accuracy of $\pm(1\%$ of reading + 1 V). Measured values are displayed not only during a test, but while a program is being executed. A digital ammeter with an accuracy of $\pm(3\%$ of reading + 20 μ A) is also provided for hipot testing. Kikusui's predecessors had the highest measurement resolution of about 1 mA , with an accuracy of $\pm5\%$ of the upper cutoff current when it is set to 100 mA. In contrast, the digital ammeter allows the TOS9200/9201 to make measurements at an accuracy of $\pm(3\%$ of reading + 20 μ A), even if the upper current is set to 100 mA. The ammeter displays measured values while the program executes, as well as during an AC or DC hipot test.

Туре	Display accuracy
Voltmeter for hipot testing	\pm (1% of reading + 30V)
Ammeter for hipot testing	\pm (3% of reading + 20µA)
Voltmeter for insulation resistance testing	± (1% of reading + 1V)
Insulation resistance meter	± (2% of reading)*
*At 1 μ A + more urad surrout < 1 mA	

*At 1 µA< measured current ≤ 1 mA</p>

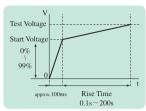


Hipot Tester with Insulation Resistance Test

Diverse functions

Rise-time control function

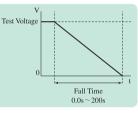
In AC hipot testing, DC hipot testing and insulation resistance testing, you can apply a voltage gradually to reach the test voltage, instead of applying the test voltage directly at the start of a test. The voltage increase time can be set to 0.1 s through 99.9 s at a resolution of 0.1 s, and to 100 s to 200



s at a resolution of 1 s. The start voltage is also adjustable between 0% and 99% at a resolution of 1%.

Fall-time control function

In AC hipot testing, you can gradually decrease the test voltage after a PASS judgment. The voltage fall time is adjustable between 0.0 s and 99.9 s at a resolution of 0.1 s, and between 100 s and 200 s at a resolution of 1 s.



Offset cancel function

In AC hipot tests that require high sensitivity and high voltages, currents flowing into the stray capacity of the test lead wire, jigs, and other components can cause measurement errors. The TOS9200/9201 features a function to cancel these offset currents.

Voltage hold function

During measurement, this function allows you to hold the value of the voltage measured at the end of an AC or DC hipot test, as long as the test results are being displayed. When combined with the rise-time control function, this function enables to observe the insulation breakdown voltage.

Maximum Leakage current and minimum resistance hold function

By selecting "MIN/MAX Mode" in the measurement mode settings, you can hold the maximum current in hipot testing and the minimum resistance after the judgment wait time in insulation resistance testing. These values are shown on the tester's display. They can also be read back via interface (GPIB or RS-232C).

Output voltage monitoring function

When the output voltage deviates from $\pm(10\%$ of setting + 50 V), the monitoring function activates to suspend the test, thus ensuring highly reliable testing.

Current detection response speed adjustment function

This function switches current detection response speeds for UPPER judgment by adjusting the integrated time constant of the current detection circuit. Three modes are available for the integrated time constant: SLOW (about 40 ms),MID (about 4 ms) and FAST (about 0.4 ms). SLOW mode is used in normal operations. MID and FAST modes are more effective in detecting a discharge occurring instantaneously or containing a large number of frequency components. They are also useful for hipot tests of test devices that insulation likely be breakdown, such as small electronic components.

Memory function

Up to 100 test conditions used in AC and DC hipot testing and insulation resistance testing, such as the test voltage, judgment value and test time, can be stored with a specific name. For instance, you can store the name of an applied safety standard and the destination of the product to be tested. If test conditions are preset, operator can recall relevant test conditions simply by entering the memory number. If you previously assigned a special name to each of these test conditions, operator can check recalled test conditions by name. The memory function allows you to recall test conditions not only through the recall operation on the front panel, but also by remote control.

[Storable test conditions]

	AC withstanding voltage testing	DC withstanding voltage testing	Insulation resistance testing
Test voltage	~	~	~
Test frequency	v		
Lower cutoff value	~	~	v
ON/OFF of the lower judgment function	V	4	v
Upper cutoff value	~	~	~
ON/OFF of the upper judgment function			¥
ON/OFF of the offset function	v		
Test time and ON/OFF of the timer function	v	4	v
Start voltage	~	~	
Voltage rise time	v	v	¥
Voltage fall time	~		
Judgment wait time		 	 ✓
Test voltage range	~		
SLOW/MID/FAST settings for the response filter	v		
FLOAT/GND of the LOW terminal	V	~	~
HIGH/LOW/OPEN settings for the scanner channel	4	~	~
ON/OFF of the contact check function	4	~	~

Program function

By coordinating test conditions stored in an AC hipot test, DC hipot test, and insulation resistance test, operator can sequentially run tests that comprise up to 100 steps. When used together with the ground bond tester TOS6200/6210, the TOS9200 Series permits continuous tests combining test conditions stored in the TOS6200, as well as on the TOS9200 itself. Sequential tests are possible, for example, on AC hipot, insulation resistance, DC hipot, and ground bond, in order. The TOS9200 Series stores up to 500 steps and 100 programs, which can be recalled through the recall operation on the front panel or by remote control.

[Sample program]

St	tep 00	Ste	ep 01	St	ep 02	
Memory	Interval	Memory	Interval	Memory	Interval	
ACW01	0.2s	DCW01	0.2s	IR01	0.2s	END

At Step 00, Step 01 and Step 02, memory ACW01 (AC hipot test), DCW (DC hipot test: TOS9201 only) and IR01 (insulation resistance test) are performed, receptively, in succession at 0.2-second intervals.

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Interfaces

REMOTE connector & SIGNAL I/O connector

The REMOTE connector on the front panel is intended exclusively for Kikusui's options (remote control/ test probe). It allows start and stop



operations by remote control. The SIGNAL I/O connector on the rear panel permits operator to recall panel memory and program memory contents by remote control, as well as controlling start and stop operations. Seven different signals are output from the SIGNAL I/O connector through the open collector.

[SIGNAL I/O]

No. Signal name I/O Details of signal 1 PM0 I LSB, LSD *1 [Pin Configuration for the SIGNAL I/O Connector] 2 PM1 I LSD *1 [SIAL I/O Connector] 3 PM2 I LSD *1 [SIAL I/O Connector] 4 PM3 I LSD *1 [SIAL I/O Connector] 5 PM4 MSD *1 [Sial 21 10 9 8 7 6 5 4 3 2 1] [Sial 21 20 20 20 20 20 20 20 20 20 20 20 20 20								
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24 +24V Output terminal for +24 V internal power, with a maximum output current of 100 mA	22	STOP	1					
current of 100 mA	23	ENABLE	1	Input terminal for the ENABLE signal for the START signal				
	24	+24V						
25 COM Circuit common (chassis potential)				current of 100 mA				
	25	COM		Circuit common (chassis potential)				

 Input signal [Low active control input High-level input voltage: 11 V to 15 V / Low-level input voltage: 0 V to 4 V / Low-level input current: Maximum –5 mA / Input interval: Minimum 5 ms]

- Output signal [Open collector output (DC4.5V to 30V) / hipot: DC 30 V / Output saturation voltage : Approximately 1.1 V (25 °C) /Maximum output current : 400 mA (TOTAL)]
- * The input signal circuit is pulled up to +12V. Therefore, opening the input terminal is equivalent to inputting a high-level signal.
- 1 2-digit BCD low active input Signal input terminal for selection between the panel memory for ACW, DCW, and IR, and the program memory for AUTO Memory recall by latching this selection signal at the rise of the strobe signal

*2 2-bit low active input

e input	Test mode	ACW	DCW	IR	AUTO	
	MODE0	Н	L	Н	L	
	MODE1	Н	Н	L	L	

GPIB/RS-232C interface

A GPIB/RS-232C interface is provided as a standard feature to facilitate the remote control of all functions of the TOS9200/9201



except the POWER switch, the KEYLOCK function, and the program execution (AUTO) function.

RS-232C [Baud rate: 9600/19200/38400 bps/TOS6200/6210 interface (AUTO mode only): START/STOP control, test condition settings, reading of TOS6200/6210 measured values, and measurement results]

GPIB [Remote control of all functions except the POWER switch, the KEYLOCK function, and the program execution (AUTO) function/SH1, AH1, T6, TE0, L4, LE0, SR1, RL1, PP0, DC1, DT0, C0, E1]

Peripheral devices

High-voltage scanner TOS9220/TOS9221

TOS9221 Front View (same for TOS9220)



TOS9221 TOS9220

The high-voltage scanner TOS9220/TOS9221 has a function that distributes the test voltage provided by the TOS9200/9201 to multiple test points. Up to four channels can be used for outputs on this scanner. Each channel can be set to one of the three electric potential modes – HIGH, LOW, or OPEN. Operator can conduct AC/DC hipot and insulation resistance tests on any of the four test points. Furthermore, up to four scanners can be connected to the tester, allowing a maximum of 16 channels. The TOS9200 is equipped with a "contact check function" to check the contact between the output of each channel and a test point. These features ensure highly reliable and labor-saving hipot and insulation resistance tests for electrical and electronic equipment with multiple test points.

*Pictures below are showing rear views of the units with cable clamp of output terminal removed.





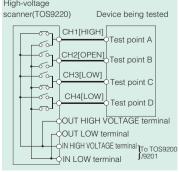
TOS9220 Rear View



Operation of the high-voltage scanner

On the TOS9200/TOS9201, you can select an electric potential mode for each channel-HIGH(high voltage side), LOW (low voltage side), and OPEN (open mode). The high-voltage scanner

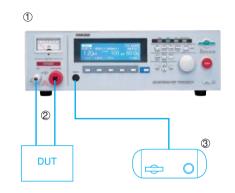
permits AC/DC hipot or insulation resistance tests on any of the four test points A to D. For instance, you can set CH1 (test point A) to HIGH,CH2 (test point B) to OPEN,and CH3 (test point C)CH4 (test point D)to LOW. To specify these settings, you can use the TOS9200/9201 panel or the GPIB/RS-232C.



Hipot Tester with Insulation Resistance Test

For Stand alone use···

Example of system for applying voltage by Test Lead or start/stop operation by Remote Control Box.

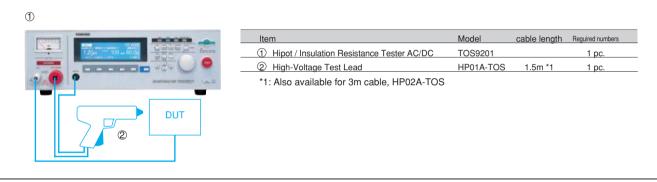


Item	Model	cable length	Reguired numbers
Hipot / Insulation Resistance Tester AC/DC	TOS9201		1 pc.
② High-Voltage Test Lead	TL01-TOS	1.5m *1	1 set
③ Remote Control Box	RC01-TOS *2	1.5m	1 pc.

*1: Also available for 3m cable, TL02-TOS

*2: Also available for both-hands operation, RC02-TOS

Example of system for applying voltage or start/stop operation by High-Voltage Test Probe.



For Multiple Channel Testing by High Voltage Scanner…

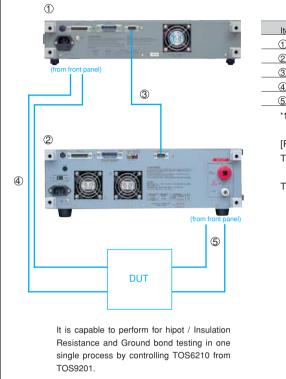
Example of system consisting TOS9201 and TOS9221 \times 2sets (8CH)

Item			Model	cable length	Reguired numbers
1 High-Voltage Sca	anner		TOS9221		2 pc.
② Hipot / Insulation	Resistance	e Tester AC/DC	TOS9201		1 pc.
③ Interface cable			85-50-0210	0.5m *1	2 pc.
④ High-Voltage Tes	st Lead (red	(b	TL07-TOS	1.5m	8 pc.
5 High-Voltage Lea	ds for Para	allel connection	TL06-TOS	0.5m *2	2 set
*1: Also available f *2: Also available f		·			
[Rack mount brack	et]				
TOS9200 / 9201	(JIS)	KRB150-TOS			
	(EIA)	KRB3-TOS			
TOS9220 / 9221	(JIS)	KRB100-TOS			
	(EIA)	KRB2-TOS			
[CAUTION] In cas to rack mount or lo and it should not b	cate thes	e units to the side	e of Hipot / Ins	ulation Resista	ance Tester,

Hipot Tester with Insulation Resistance Test

Single process to apply until ground bond test...

Example of system consisting TOS9201 and TOS6210



ltem			Model	cable length	Reguired numbers
① Ground Bond Te	ster		TOS6210		1 pc.
 Hipot / Insulation 	Resistanc	e Tester AC/DC	TOS9201		1 pc.
③ RS-232C Cross	Cable (9pir	n female-9pin female)		1 pc.
④ Low-Voltage Tes	t Lead		TL12-TOS	1.5m	1 set
⑤ High-Voltage Ter	st Lead		TL01-TOS	1.5m *1	1 set
*1: Also available f	ior 3m cal	ole, TL02-TOS			
[Rack mount brack	ket]				
TOS9200 / 9201	(JIS)	KRB150-TOS			
	(EIA)	KRB3-TOS			
TOS6210 / 6200	(JIS)	KRB100-TOS			

KRB2-TOS

(EIA)

Fully Automated System by PC···

Example of system consisting TOS9201, TOS9221 (4CH) and TOS6210

ᠿ 5 4 6 to DUT 2 8 3 front par \bigcirc 9 8 to DUT Possible to control TOS9201 and TOS6210 and acquire the test result.

Model cable length Reguired numbers Item 1 High-Voltage Scanner TOS9221 1 pc. ② Hipot / Insulation Resistance Tester AC/DC TOS9201 1 pc. ③ Ground Bond Tester TOS6210 1 pc ④ Interface cable 85-50-0210 0.5m *1 1 pc 5 High-Voltage Test Lead (red) TL07-TOS 1.5m 4 pc. 6 High-Voltage Leads for Parallel connection TL06-TOS 0.5m *2 1 set ⑦ Low-Voltage Test Lead TL12-TOS 1.5m 1 set 8 GPIB Cable 408J-102 2m *3 2 pc 9 PC (with GPIB Interface cable) 1 pc. *1: Also available for 2m cable, DD2M-8P *2: Also available for 1.5m cable, TL04-TOS *3: Also available for 1m cable, 408J-101 and 4m cable, 408J-104 [Rack mount bracket] TOS9200 / 9201 (JIS) KRB150-TOS KRB3-TOS (EIA) TOS9220 / 9221 / 6210 / 6200 (JIS) KRB100-TOS (EIA) KRB2-TOS

[CAUTION] In case of use for combining more than 2sets of High Voltage Scanner unit and Ground Bond Tester, it is required to rack mount or locate these units to the side of Hipot / Insulation Resistance Tester, and it should not be piled up more than 2sets of High Voltage Scanner units.

Hipot Tester with Insulation Resistance Test

Hipot test mode

Item		TOS9200	TOS9201		
Dutp	put section				
	Output-voltage range	0.05 kV to 5.00 kV AC			
	Resolution	10 V			
	Accuracy	±(1.5% of setting + 2	20 V) [with no load]		
	Maximum rated load (*1)	500 VA (5 k	V/100 mA)		
	Maximum rated current	100 mA [output volta;	ge of 0.2 kV or more]		
	Transformer capacity	500	VA		
١C	Output-voltage waveform(*2)	Sine	wave		
	Distortion	2% or less [with no load or pure resistive load	at output voltage of 0.5 kV or more applied]		
	Frequency	50 Hz/	/60 Hz		
	Accuracy	±0.	1%		
	Voltage regulation	±3% or less [maximum	rated load \rightarrow no load]		
	Short-circuit current	200 mA or more, 350 mA or less [a	t output voltage of 0.5 kV or more]		
	Type of output	PWM sv	vitching		
	Output-voltage range		0.05 kV to 6.00 kV DC		
	Resolution		10 V		
	Accuracy		$\pm(1.5\%$ of the setting + 20 V)		
	Maximum rated load (*1)		50 W (5 kV/10 mA)		
C	Maximum rated current		10 mA		
n.	Ripple No load at 5 kV		50 Vp-р Тур.		
	Maximum rated load		150 Vp-р Тур.		
	Voltage regulation		1% or less [maximum rated load \rightarrow no load]		
	Short-circuit current		40 mA Typ.		
	Discharge function		Forced discharge at the end of test(discharge resistance: 125 k Ω)		
art	voltage	The voltage at the start of the test	st can be set as the start voltage.		
	Setting range	0% to 99% of the test vo	ltage (resolution of 1%)		
utp	out-voltage monitoring function	If the output voltage exceeds $\pm(10\%)$ of the setting + 50 V	7), output is cut off and the protection function activates.		
oltı	meter				
	Scale	6 kV AC	/DC F.S		
nal	og Accuracy	±5%	F.S		
	Indicator	Mean-value responsive/roo	ot-mean-square value scale		
	Measurement range	0.0 kV to 6.0	0 kV AC/DC		
	Resolution	10	V		
igit	tal Accuracy	±(1.0% of the r	eading + 30 V)		
	Response	Mean-value responsive/root-mean-square	e value display (response time of 200 ms)		
	TTOT D A				

HOLD function The voltage measured at the end of test is held during the PASS and FAIL judgment time period.

*1 Time limitation on output

The tester's hipot generator is designed to radiate half as much heat as the rated output, in consideration of the size, weight, cost, and other factors of the tester. It is therefore necessary to use the tester within the ranges specified below. Operations deviating from these ranges may heat the output section excessively, thereby activating the protective circuit. In such a case, suspend the test and wait until the temperature falls to the normal level.

[Output limitation in hipot testing (Output time = voltage rise time + test time + voltage fall time)]

Ambient temperature		Upper current	Pause Time	Output time
t ≤ 40 ºC	AC	50< i ≤ 110 mA	At least as long as the output time	Maximum of 30 minutes
	AC	i ≤ 50 mA	Not necessary	Continuous output possible
	DC	5< i ≤ 11 mA	At least as long as the output time	Maximum of 1 minute
	DC	i≤5 mA	At least as long as the judgement wait time (WAIT TIME)	Continuous output possible

*2 Test-voltage waveform

When an AC test voltage is applied to a capacitive load, it is possible that the voltage becomes higher even than that when in the no load state. Furthermore, waveform distortion also may occur if the capacitance of the load is voltage-dependent (such as of ceramics capacitors). When the test voltage is not higher than 1.5 kV and the capacitance is not larger than 1000 pF, such test voltage changes are only of negligible levels. As the output type of the high-voltage generator block of the tester is PWM switching, switching noise and spike noise that the test voltage includes increase when the test voltage is 500 V or less. The lower the test voltage is, the more the waveform distortion increases.

Item		TOS9200			TOS9201		
Ammeter(*3)							
Measurement range		0.00 mA to 110 m	A AC		0.00 mA	to 110 mA AC/0.0	0 mA to 11 mA DC
		i < 1 mA	$1 \text{ mA} \le i < 10 \text{ mA}$	$10 \text{ mA} \le i < 100 \text{ mA}$		100 mA ≤ i	
Display		μΑ	□.□ □ mA	🗆 🗆 mA		🗆 🗖 🗖 mA	i = measured current
Accuracy		±(3% of the reading	ng + 20 μ A) [after the offset car	cel function is activated	d, if the so	canner is mounted]	
Response		Mean-value response	nsive / root-mean-square value	display (response time of	of 200 ms	5)	
Hold function		The measured curr	rent at the end of the test is held	during the PASS judgr	nent time	e period.	
Offset cancel function	1	The current flowing to the insulation resistor between the output cables and the stray capacity is cancelled up to $100 \ \mu A/kV$ (in AC hipot testing only).					
Calibration		Performs calibration using the root-mean-square value of a sine wave with a pure resistive load					
Selection of LOW/GUA	RD for the GND (*4)	Selection permitted for current measurement between the mode for the GND point connected to the LOW terminal, and the mode using guard.					
	LOW	Connects the GND point to the LOW terminal. Measures the current flowing to the LOW terminal (chassis) (for normal operation).					sis) (for normal operation).
	GUARD	Sets the GND point as guard. Measures the current flowing to the LOW terminal, but does not measure the current flowing to the chassis (for high-sensitivity, high-accuracy measurements).					
Time							
Setting range for the voltage	e rise time (RISE TIME)	0.1 s to 200 s					
Setting range for the volta	age fall time (FALL TIME)	0 s to	200 s (Valid only with PASS ju	udgement)		0 s to 200 s (Valid only	with PASS judgementin AC hipot testing)
Setting range for the test	t time (TEST TIME)	0.3 s to 999 s With the TIMER OFF function					
Setting range for the judgement wait time (WAIT TIME)			0.3 s to 10 s (Only for DC hipot testing)[RISE TIME + TEST TIME >			ot testing)[RISE TIME + TEST TIME > WAIT TIME]	
Accuracy		$\pm (100 \text{ ppm} + 20 \text{ ms})$					

Hipot Tester with Insulation Resistance Test

T		TOSO200		TO20201	1	
Item	TOS9200 TOS9201					
Judgement function						
Judgement method/action	Judgement	Judgement method		Display	Buzzer	SIGNAL I/O
	UPPER FAIL	When the tester detects a current exceeding the uppe	r current,	The FAIL		Outputs the
		it cuts off the output and makes an UPPER FAIL jud	gement.	LED lights up.	ON	U FAIL signal
		In DC hipot testing, however, no judgement is made		Displayed		
		until the judgement wait time (WIT TIME) has elaps	ed.	on the LCD		
	LOWER FAIL	When the tester detects a current below the lower cur	rrent,	The FAIL		Outputs the
		it cuts off the output and makes a LOWER FAIL jud	gement.	LED lights up.	ON	L FAIL signal
		However, no judgement is made during the voltage r	ise time (RISE TIME)	Displayed		
		or voltage fall time (FALL TIME) in AC hipot testin	g.	on the LCD		
	PASS	PASS When the preset time has elapsed without any abnormalities,		The PASS		Outputs the
	the tester cuts off the output and makes a PASS judgement.		LED lights up.	ON	PASS signal	
				Displayed	ON	
				on the LCD		
	• The PASS signal is output at the timing preset on PASS HOLD. If HOLD is set, the PASS signal is output cont			ut continu	ously until	
	the STOP signal is input.			, ,		
	• The UPPER FAIL signal and the LOWER FAIL signal are output continuously until the STOP signal is input.					
	• The FAIL and PASS buzzer volumes are adjustable. However, they cannot be adjusted individually, as they are set in common.			in common.		
Setting range for the upper current (UPPER)	0.01 mA to 110 mA AC 0.01 mA to 1		110 mA AC / 0.01 mA to 11 mA DC			
Setting range for the lower current(LOWER)	0.01 mA to 110 mA AC(With the LOWER OFF function) 0.01 mA to 110 mA AC/0.01 mA to 11 mA D			C (With the	LOWER OFF function)	
Judgement accuracy (*3)	$\pm(3\% \text{ of setting} + 20 \mu\text{A})$ [After the offset cancel function is activated, if the scanner is mounted]					
Current detection method	The absolute current values are integrated and compared with the reference value.					
Response-speed switching function	The current-detection response speed for UPPER FAIL judgement can be set to FAST/MID/SLOW (for AC hipot testing only).					
*3 In AC hipot testing, a current flows into the stray	*3 In AC hipot testing, a current flows into the stray capacity of measurement leadwire and fixtures. When the optional high-voltage scanner TOS9220/9221 is used, a current of					
approximately 22 µA/kV flows into the stray capacity of each scanner. The table below shows the approximate currents flowing into such stray capacity.						
When the LOW terminal is set to GND, a current flowing into the stray capacity is added for measurement purposes to the current flowing into the DUT. In particular, for high-sensitivity, high-						
accuracy judgement, it is necessary to add the cur	accuracy judgement, it is necessary to add the current flowing into the stray capacity to the lower/upper current. When the LOW terminal is set to FLOAT, the effect of the current flowing into					

the stray capacity is negligible. If the offset caref function is used, the current flowing into the stray capacity can be eliminated from the measurement.

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Output voltage	1kV	2kV	3kV	4kV	5kV
Hanging a 350-mm test lead wire (Typ. value)	2 μΑ	4 μΑ	6 μΑ	8 μΑ	10 µA
Using the accessory leadwire TL01-TOS (Typ. value)	16 µA	32 µA	48 µA	64 µA	80 µA
High-voltage scanner (Typ. value, not including the test leadwire)	22 μΑ	44 μΑ	66 µA	88 µA	110 µA

*4 With the GND set to GUARD, current measurement is disabled if the part of the DUT connected to the LOW terminal is grounded, which poses extreme danger. Never ground the DUT. In ordinary operation, set the GND to LOW.

Insulation Resistance Testing Mode

Item	-	TOS9200 TOS9201			TOS9201		
Output section							
Output-voltage range		-25 V to -1000 V DC					
	Resolution		1 V				
	Setting accuracy			±(1.5 % of Set	ting + 2 V)		
Maximum rated load	1			1 W (-1000 V	DC/1 mA)		
Maximum rated curr	rent			1 m/	A		
Ripple	1 kV no-load			2 Vp-p o	r less		
	Maximum rated load			10 Vp-p o	or less		
Voltage regulation				1% or less [Maximum ra	ated load \rightarrow no load]		
Short-circuit current				12 mA o	r less		
Discharge function					t (discharge resistance : 25 kΩ)		
Output-voltage mon	itoring function	If th	he output voltage exceeds ±(10)	% of the setting + 50 V)	, output is cut off and the protection function activates.		
Voltmeter							
Analog	Scale			6 kV AC/I	DC F.S		
	Accuracy	±5% F.S					
	Indicator	Mean-value responsive / root-mean-square value scale			t-mean-square value scale		
Digital	Measurement range	e 0 V to -1200 V					
	Resolution	1 V					
	Accuracy		$\pm (1 \% \text{ of reading} + 1 \text{ V})$				
Resistance meter							
Measurement range		0.01 ΜΩ - 9.99 GΩ	(Within the maximum rated cu	irrent range of 1 mA to 5	50 nA)		
Display		R < 10.0 MΩ	$10.0M\Omega \le R < 100.0M\Omega$	$100.0M\Omega \le R < 1.0$	$1.00G\Omega \le R \le 9.99G\Omega$		
			ΜΩ	ΟΟΜΩ	\Box \Box \Box \Box \Box \Box \Box Ω R = measured insulation resistance		
Accuracy		$50 \text{ nA} \le i \le 100$	nA 100 nA < i ≤ 200 nA	$200 \text{ nA} < i \leq 1 \ \mu\text{A}$	$1 \mu\text{A} < i \le 1 \text{mA}$		
		± (20 % of readi	ng) $\pm (10\% \text{ of reading})$	± (5 % of reading)	\pm (2 % of reading) i = measured current		
		[In the humidity range of 20 %rh to 70 %rh (no condensation), with no disturbance such as swinging of the test leadwire]					
Hold function		The measured current at the end of the test is held during the PASS period.					
Selection of LOW/0	Selection of LOW/GUARD for the GND (*5)		Selection permitted for current measurement between the mode for the GND point connected to the LOW terminal, and the mode using guard.				
LOW		Connects the GND point to the LOW terminal. Measures the current flowing to the LOW terminal (chassis) (for normal operation).					
	GUARD	Sets the GND point as guard. Measures the current flowing to the LOW terminal, but does not measure the current					
		flowing to the chassis (for high-sensitivity, high-accuracy measurements).					
	1			2	,		

Hipot Tester with Insulation Resistance Test

Item	TOS9200				TOS9201		
Judgement function							
Judgement method/action	Judgement Judgement method			Display	Buzzer	SIGNAL I/O	
	UPPER FAIL	UPPER FAIL When the tester detects a resistance exceeding the upper cutoff resistance, T				ON	Outputs the
		it cuts off the output and	d makes an UPPER FAI	L judgement. However,	LED lights up.		U FAIL signal
					Displayed		
					on the LCD The FAIL		
						ON	Outputs the
		-	d makes a LOWER FAII intil the judgement wait	0 0	LED lights up. Displayed		L FAIL signal
		has elapsed.	intil the judgement wait	time (WAIT TIME)	on the LCD		
	PASS	1	as elapsed without any al	mormalities	The PASS	ON	Outputs the
	1 A55	*	tput and makes a PASS		LED lights up.	ON	PASS signal
		the tester eats on the of	apar and mates a Triss	Judgement	Displayed		11100 orginal
					on the LCD		
	• The PASS signal	is output at the timing	preset on PASS HOL	D. If HOLD is set, the	PASS signal is outpu	t continuo	uslv until
		 The PASS signal is output at the timing preset on PASS HOLD. If HOLD is set, the PASS signal is output continuously unt the STOP signal is input. 					
	• The UPPER FAIL signal and the LOWER FAIL signal are output continuously until the STOP signal is input.						
	• The FAIL and PA	ASS buzzer volumes a	e adjustable. However	, they cannot be adjust	ed individually, as the	ey are set	in common.
Setting range for the upper resistance (UPPER)		0.01 M Ω to 9.99 G Ω [Below the maximum rated current]					
Setting range for the lower resistance (LOWER)		0.	01 MΩ to 9.99 GΩ [B	elow the maximum rat	ted current]		
Judgement accuracy	Judgement current		50 nA ≤ i ≤ 100 nA	100 nA < i ≤ 200 nA	200nA < i ≤ 1 μA	1 μA < i s	≤1 mA
For both UPPER and LOWER	UPPER, LOWER	$0.01 \leq R < 10.0 \; M\Omega$	-	-		± (2 % of s	setting + 3digit)
		$10.0 \le R < 50.0 \ M\Omega$	_	_	± (5 % of setting + 5digit)	± (2 % of s	etting + 3digit)
		$50.0 \le R < 100 M\Omega$	-	-	± (5 % of setting + 5digit)	± (2 % of s	setting + 3digit)
		$100 \text{ M}\Omega \leq \text{R} < 200 \text{ M}\Omega$	_	± (10 % of setting + 5digit)	± (5 % of setting + 5digit)	± (2 % of s	setting + 3digit)
		$200~M\Omega \le R < 500~M\Omega$	± (20 % of setting + 5digit)	± (10 % of setting + 5digit)	\pm (5 % of setting + 5digit)	± (2 % of s	setting + 3digit)
		$500~M\Omega \le R < 1.00~G\Omega$	\pm (20 % of setting + 5digit)	± (10 % of setting + 5digit)	\pm (5 % of setting + 5digit)	± (2 % of s	setting + 3digit)
		$1.00~G\Omega \le R < 2.00~G\Omega$	± (20 % of setting + 10digit)	± (10 % of setting + 5digit)	\pm (5 % of setting + 5digit)		—
		$2.00~G\Omega \le R < 5.00~G\Omega$	± (20 % of setting + 20digit)	± (10 % of setting + 10digit)	\pm (5 % of setting + 5digit)		-
		$5.00~G\Omega \le R < 10.0~G\Omega$	± (20 % of setting + 20digit)	± (10 % of setting + 10digit)	_		-
	Judgement current = test voltage/(UPPER,LOWER)						
	[In the humidity range of 20 %rh to 70 %rh (no codensation), with no disturbance such as swinging of the test leadwire]						
	[In LOWER judgement, at least 0.5 s is necessary for testing after the WAIT TIME has elapsed. In LOWER judgement for 200 nA or lower, a wait time of at least 1.0 s is necessary.]				ent		
Time	1						
Setting range for the voltage rise time (RISE TIME)		0.1 s to 200 s					

Setting range for the voltage rise time (RISE TIME)	0.1 s to 200 s
Setting range for the test time (TEST TIME)	0.5 s to 999 s With the TIMER OFF function
Setting range for the judgement wait time (WAIT TIME)	0.3 s to 10 s [RISE TIME + TEST TIME > WAIT TIME]
Accuracy	$\pm (100 \text{ ppm} + 20 \text{ ms})$

*5 When the GND is set to GUARD, current measurement is disabled if the part of the DUT connected to the LOW terminal is grounded, which poses extreme danger. Never ground the DUT. In ordinary operation, set the GND to LOW.

General Specifications

	meations					
Item		TOS9200	TOS9201			
Environment						
Installation location		Indoors at an altitude of up to 2000 m				
Warranty range Temperature Humidity		5 °C to 35 °C				
		20 %rh to 80 %rh (No condensation)				
Operating range	Temperature	0 °C to 40 °C				
	Humidity	20 %rh to 80 %rh (No condensation)				
Storage range	Temperature	-20 °C	to 70 °C			
	Humidity	90 %rh or less (1	No condensation)			
Power requirements						
Nominal voltage range (A	llowable voltage range)	100 V to 120 V AC / 200 V to 240 V AC (85 V to 130 V AC / 170 V to 250 V AC) Selectable				
Power consumption Using no load (READY) Using the rated load		100 VA or less				
		Maximum of 800 VA				
Allowable frequency range		47 Hz t	to 63 Hz			
Insulation resistance		30 MΩ or more (500 V DC) [be	tween the AC LINE and chassis]			
Hipot		1390 V AC, 2 seconds, 20 mA or less [between the AC LINE and chassis]				
Ground bond		25 A AC/0.1 Ω or less				
Electromagnetic compatibility (EMC) (*6)		Conforms to the requirements of the following directive and standard.				
		EMC Directive 89/336/EEC, EN61326, EN61000-3-2, EN61000-3-3				
		Under following conditions				
		1. Used test leadwire TL01-TOS which is supplied. 2. No discharge occurs at outside of the tester.				
		3. Used the shielded cable which length is less than three meters when the SIGNAL I/O is used.				
Safety (*6,7)		Conforms to the requirements of the following directive and standard. Low Voltage Directive 73/23/EEC, EN61010-1, Class I, Pollution degree 2				
		, , , ,				
Dimensions (maximum)		430 (455) W x 132 (150) H x 370 (440) D mm				
Weight		Approx. 19 kg				

Hipot Tester with Insulation Resistance Test

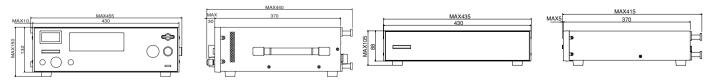
Item		TOS9200	TOS9201			
Accessory						
AC Power cable		1 pc.				
High-voltage test lead wire TL01-TOS (1.5 m)		1 set				
Interlock jumper		1 pc.				
High-Voltage Dange	er seal	1 sheet				
Fuse		1 pc.				
Operation Manual		Operation Manual for Tester: 1 copy, Operation for GPIB/RS-232C	Interface: 1 copy			
		panel. Not applicable to custom order models. e to ground the protective conductor terminal of the instrument. The safety o	f the instrument is not guaranteed unless the instrument is grounded properly.			
Electrical per						
Item		TOS9200	TOS9201			
Maximum rating	AC		5.0 kV			
voltage	DC		6.0 kV			
Number of channels		4 (Each channel is sett	table to HIGH, LOW, or OPEN.)			
Maximum number of	f scanners connected		d in order of connection to the TOS9200/9201 tester. H8 3 rd scanner CH9 to CH12 4 th scanner CH13 to CH16			
Contact check function	on	None (*1)	Provided			
Lamps and LEDs	POWER		POWER switch of the TOS9200/9201 tester			
•	DANGER		DANGER lamp of the TOS9200/9201 tester			
	CHANNEL		GH: red; LOW: green; Under contact check: orange			
Power requirements			- · · ·			
Nominal voltage range (a	allowable voltage range)	100 V to 120 V AC/200 V to 240 V AC (85 V	to 132 V AC/170 V to 250 V AC) Automatic switching			
Power consumption	In READY state	Ar	pprox. 12 VA			
	During test	40 '	VA maximum			
Allowable frequency range		47 Hz to 63 Hz				
Insulation resistance		$30 \text{ M} \Omega \text{ or more} (500 \text{ V DC})$ [between the AC LINE and chassis]				
Hipot		1390 V AC, 2 seconds, 10 mA o	or less [between the AC LINE and chassis]			
Ground bond		25 A /	AC/0.1 Ω or less			
Electromagnetic compatibility (EMC) (*2)		Conforms to the requirements of the following directive and standard. EMC Directive 89/336/EEC, EN61326, EN61000-3-2, EN61000-3-3 Under following conditions 1. Used test leadwire TL07-TOS which is supplied. 2. No discharge occurs at outside of the tester. 3. Used the shielded cable which length is less than three meters when the SIGNAL I/O is used.				
Safety (*2,3)			Conforms to the requirements of the following directive and standard. Low Voltage Directive 73/23/EEC, EN61010-1, Class I, Pollution degree 2			
Environment		,,, _,, _				
Installation location		Indoors and a	t altitudes up to 2000 m			
Warranty range	Temperature		°C to 35 °C			
	Humidity	20 %rh to 80	%rh (no condensation)			
Operating range	Temperature		°C to 40 °C			
	Humidity	20 %rh to 80	%rh (no condensation)			
Storage range Temperature		-20	0 °C to 70 °C			
	Humidity	90 %rh or less (no condensation)				
Dimensions		430(435)W × 88(105)H × 370(415) Dmm				
Weight		Approx. 6.5 kg				
Accessories						
AC power cable			1 pc.			
High-voltage test leadwires, red		4 pc. (1.5 m each)	8 pc. (1.5 m each)			
High-voltage leads for	r parallel connection	1 set (0.5 m each)				
Interface cable		1 pc.(0.5 m)				
Channel-indication stickers		For the panel face: 1 sheet; for the test leadwires: 1				
"HIGH VOLTAGE,	DANGER" stickers	2 shets				
Fuses		2 pc. (including a spare contained in the fuse holder)				
Operation Manual		1 сору				
*2 Only on models they	t have CE morking on the r	anel. Not applicable to custom order models.				

*2 Only on models that have CE marking on the panel. Not applicable to custom order models.

*3 This instrument is a Class I equipment. Be sure to ground the protective conductor terminal of the instrument. The safety of the instrument is not guaranteed unless the instrument is grounded properly. [Measurement accuracy achieved when the scanner and the TOS9220/9201 tester are connected]

In an AC hipot test, a current of approx. 22 μ AkV flows per scanner due to stray capacitance in the scanner in comparison with use of the TOS9220/9201 tester alone. Note that this current may contribute to errors in current measurements conducted by the TOS9220/9201 tester.

External dimensional diagrams



Unit: mm

TOS5101

Hipot Tester

Output block Applied Voltage	0 to 5/0 to 10 kV AC and DC
AC	0 10 5/ 0 10 10 KV AC and DC
Maximum Rated*1	500VA / 10 kV, 50 mA
Waveform	Commercial line waveform
Voltage Regulation	Max. 15% (for max. rated load to no load)
Switching	Use of a zero turn-on switch
DC	
Applied Voltage	50W / 10 kV, 5 mA
Ripple	100 Vp-p typ. at 10 kV, no load
	200 Vp-p typ. at max. rated output
Maximum Rated*1	Max. 3% (for max. rated load to no load)
Output Voltmeters	
Analog	
Scale	10 kV full scale, AC/DC
Class	JIS Class 2.5
Accuracy	±5% of full scale
AC Indication	Mean value response / rms value scale
Digital	
Full Scale	5 kV/ 10 kV full scale
Accuracy	$\pm 1.5\%$ of full scale
AC Response	Mean value response / rms value display
Ammeter	inean varie response / mis varie dispity
Digital	
Accuracy	$\pm(5\% + 20\mu A)$ of upper cutoff current
AC Response	Mean value response / rms value display
Pass/fail Judgement Function	inean varie response / mis varie display
Type of Judgement	Window comparator type
Type of Judgement	•FAIL judgement
	*When current detected above upper cutoff current
	*When current detected below lower cutoff current
	(FAIL signal generated when FAIL judgement made) • PASS judgement
	*When set time has elapsed and no abnormality is
	detected
Upper cutoff current setting range	AC: 0.1 to 55 mA DC: 0.1 to 5.5 mA
Lower cutoff current setting range	AC: 0.1 to 55 mA DC: 0.1 to 5.5 mA
Judgement Accuracy	$\pm(5\% \text{ of upper cutoff current} + 20\mu\text{A})$
Current Detection	Integration of current absolute value fol-
	lowed by comparison with reference value.
Calibration	With rms value of sine wave using a pure
	resistance load.
No-load output voltage required for detection	Approx. 970 V when set to 50 mA AC
1 0 1	Approx. 160 V when set to 5 mA DC
Test Time Setting Range	0.5 to 999 sec (±10 ms) (timer-off function
Test Thile Setting Kunge	provided)
Accuracy	±20 ms
Line Voltage	100V±10%, 50/60 Hz (Nominal voltages of
Line voltage	110V, 120V, 220V, 230V and 240V avail-
	able as factory options.)
Downer Dogwingmants	
Power Requirements	Max. 50 VA under no-load conditions
for line voltage of 100 V	
f	/ Approx. 600 VA at rated load
for line voltage of 100 V to 200 V	Max. 50 VA under no-load conditions
C 11 12 COOO XI - O 40 XI	/ Approx. 600 VA at rated load
for line voltage of 220 V to 240 V	Max. 50 VA under no-load conditions
	/ Approx. 610 VA at rated load
Electromagnetic compatibility (EMC)	Conforms to the requirements of the
	-
	following directive and standard.*2
	following directive and standard.*2 EMC Directive 89/336/EEC
	following directive and standard.*2 EMC Directive 89/336/EEC EN61326
	following directive and standard.*2 EMC Directive 89/336/EEC EN61326 EN61000-3-2
	following directive and standard.*2 EMC Directive 89/336/EEC EN61326 EN61000-3-2 EN61000-3-3
	following directive and standard.*2 EMC Directive 89/336/EEC EN61326 EN61000-3-2 EN61000-3-3 Under following conditions
	following directive and standard.*2 EMC Directive 89/336/EEC EN61326 EN61000-3-2 EN61000-3-3 Under following conditions 1. Used HV test leadwires which is
	following directive and standard.*2 EMC Directive 89/336/EEC EN61326 EN61000-3-2 EN61000-3-3 Under following conditions 1. Used HV test leadwires which is supplied.
	following directive and standard.*2 EMC Directive 89/336/EEC EN61326 EN61000-3-2 EN61000-3-3 Under following conditions 1. Used HV test leadwires which is supplied. 2. No discharge in testing.
	 following directive and standard.*2 EMC Directive 89/336/EEC EN61326 EN61000-3-2 EN61000-3-3 Under following conditions 1. Used HV test leadwires which is supplied. 2. No discharge in testing. 3. Used the shielded cable which length is
	following directive and standard.*2 EMC Directive 89/336/EEC EN61326 EN61000-3-2 EN61000-3-3 Under following conditions 1. Used HV test leadwires which is supplied. 2. No discharge in testing.

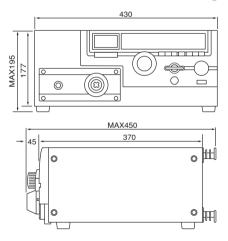
Safty	Conforms to the requirements of the follow- ing directive and standard. *2,4		
	Low Voltage Directive 73/23/EEC		
	EN61010-1		
	Class I		
	Pollution degree 2		
Insulation resistance	30 M Ω or more (500 V DC)		
Hipot	1390 VAC, 2 seconds [between the AC LINE and chassis]		
	1200 VAC, 1 second [UL-approved products only]		
Environment	Specification range : 5 °C to 35°C / 20 %rh to 80 %rh		
	Operable range : 0 °C to 40°C / 20 %rh to 80 %rh		
	Storage range : -20 °C to 70 °C / 80 %rh or less		
Dimensions (MAX)	430W × 177(195)H × 370(450)Dmm		
Weight			
for line voltage of 100 V	Approx. 21 kg		
for line voltage of 100 V to 120 V	Approx. 23 kg		
for line voltage of 220 V to 240 V	Approx. 24 kg		
Accessories			
High-voltage test lead	TL01-TOS (max.allowablevoltage: 5 kV /1.5m)		
	TL03-TOS (max.allowablevoltage: 10 kV /1.5m)		
Others	14-pin amphenol plug (assembled)		

*1: Continuous output time may be limited depending on current high limit reference value and ambient temperature.

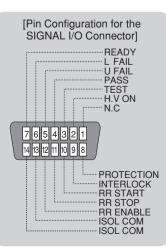
*3: Not applicable to custom order models.

*4: This instrument is a Class I equipment. Be sure to ground the protective conductor terminal of the instrument. The safety of the instrument is not guaranteed unless the instrument is grounded properly.

-External dimensional diagrams —



Unit: mm



^{*2:} Only on models that have CE marking on the panel. Not applicable to custom order models.